

Notice of References Cited	Application/Control No. 10/585,691		Applicant(s)/Patent Under Reexamination FUKUSHIMA ET AL.	
	Examiner HEE-YONG KIM		Art Unit 2621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,064,424 A	05-2000	van Berkel et al.	348/51
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*	D	US-2002/0006213 A1	01-2002	Doudnikov et al.	382/103
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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